



ISP1105/1106

Advanced USB transceivers

Rev. 10 — 28 September 2009

Product data sheet

1. General description

The ISP1105/1106 range of Universal Serial Bus (USB) transceivers are compliant with the *Universal Serial Bus Specification Rev. 2.0*. They can transmit and receive serial data at both full-speed (12 Mbit/s) and low-speed (1.5 Mbit/s) data rates. The ISP1105/1106 range can be used as a USB device transceiver or a USB host transceiver.

They allow USB Application Specific ICs (ASICs) and Programmable Logic Devices (PLDs) with power supply voltages from 1.65 V to 3.6 V to interface with the physical layer of the Universal Serial Bus. They have an integrated 5 V-to-3.3 V voltage regulator for direct powering via the USB supply V_{BUS} .

ISP1105 allows single-ended and differential input modes selectable by a MODE input and it is available in HVQFN16 and HBCC16 packages. ISP1106 allows only differential input mode and is available in both TSSOP16 and HBCC16 packages.

The ISP1105/1106 are ideal for portable electronics devices such as mobile phones, digital still cameras, Personal Digital Assistants (PDA) and Information Appliances (IA).

2. Features

- Complies with *Universal Serial Bus Specification Rev. 2.0*
- Can transmit and receive serial data at both full-speed (12 Mbit/s) and low-speed (1.5 Mbit/s) data rates
- Integrated bypassable 5 V-to-3.3 V voltage regulator for powering via USB V_{BUS}
- V_{BUS} disconnection indication through VP and VM
- Used as a USB device transceiver or a USB host transceiver
- Stable RCV output during SE0 condition
- Two single-ended receivers with hysteresis
- Low-power operation
- Supports an I/O voltage range from 1.65 V to 3.6 V
- ± 12 kV ESD protection at the D+, D-, $V_{CC(5.0)}$ and GND pins
- Full industrial operating temperature range from -40 °C to $+85$ °C
- Available in small HBCC16, HVQFN16 (only ISP1105) and TSSOP16 (only ISP1106) packages

The ISP1105 HBCC16 and HVQFN16 are lead-free and halogen-free.

The ISP1106 HBCC16 is lead-free.



3. Applications

- Portable electronic devices, such as:
 - ◆ Mobile phone
 - ◆ Digital still camera
 - ◆ Personal Digital Assistant (PDA)
 - ◆ Information Appliance (IA).

4. Ordering information

Table 1. Ordering information

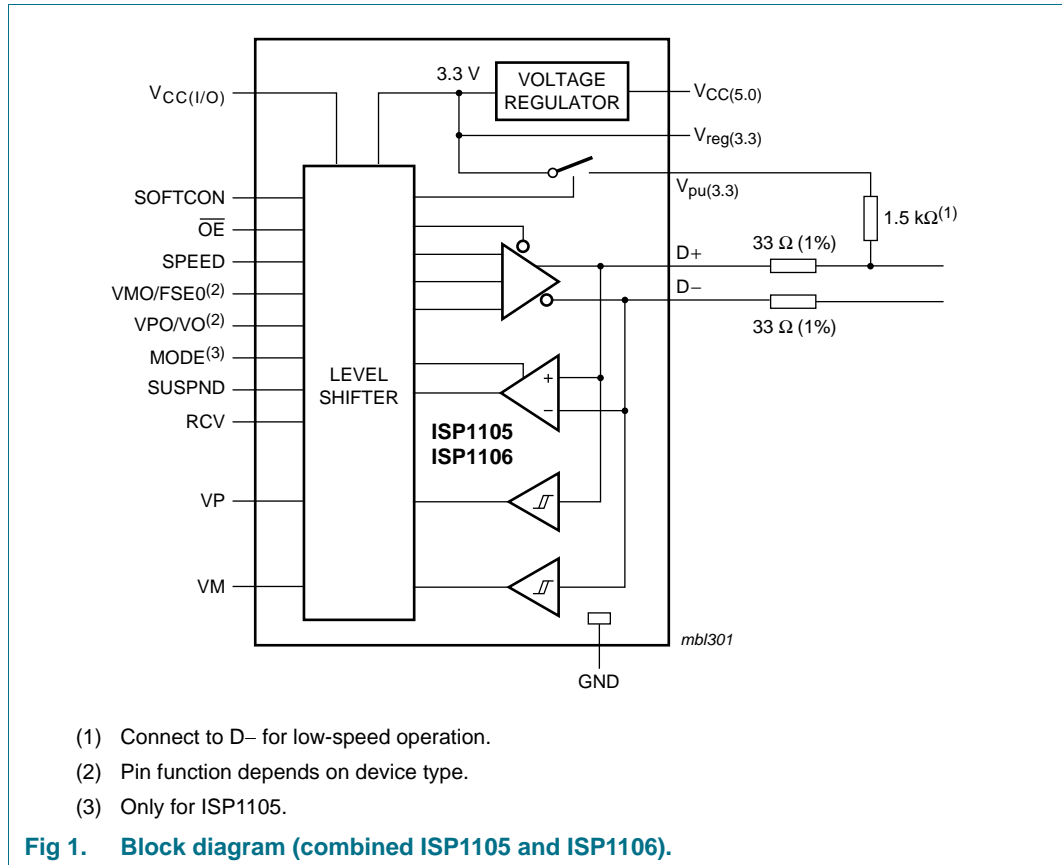
Commercial product code	Package description	Packing	Minimum sellable quantity
ISP1105BSTM	HVQFN16; 16 terminals; body 3 × 3 × 0.85 mm	13 inch tape and reel non-dry pack	6000 pieces
ISP1105WTS	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	7 inch tape and reel non-dry pack	1400 pieces
ISP1105WTM	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	13 inch tape and reel non-dry pack	6000 pieces
ISP1106WTS	HBCC16; 16 terminals; body 3 × 3 × 0.65 mm	7 inch tape and reel non-dry pack	1400 pieces
ISP1106DHTM	TSSOP16; 16 leads; body width 4.4 mm	13 inch tape and reel non-dry pack	2500 pieces

4.1 Ordering options

Table 2. Selection guide

Product	Package	Description
ISP1105	HVQFN16 and HBCC16	supports both single-ended and differential input modes; see Table 5 and Table 6 .
ISP1106	TSSOP16 and HBCC16	supports only the differential input mode; see Table 6 .

5. Block diagram



6. Pinning information

6.1 Pinning

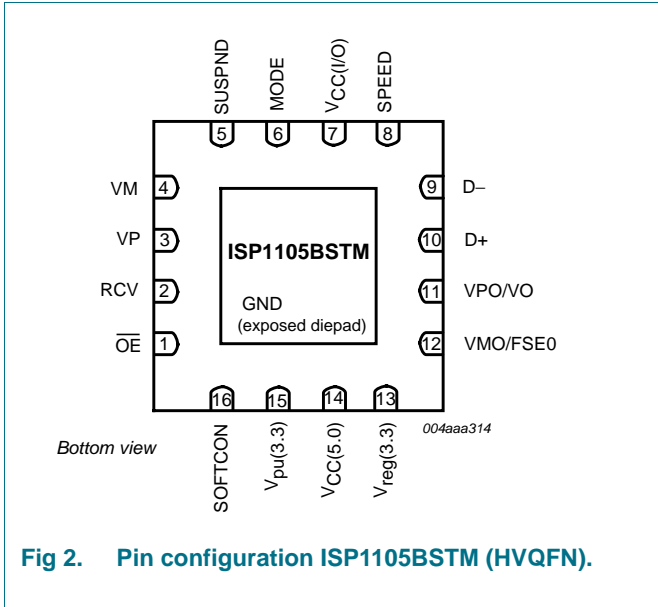


Fig 2. Pin configuration ISP1105BSTM (HVQFN).

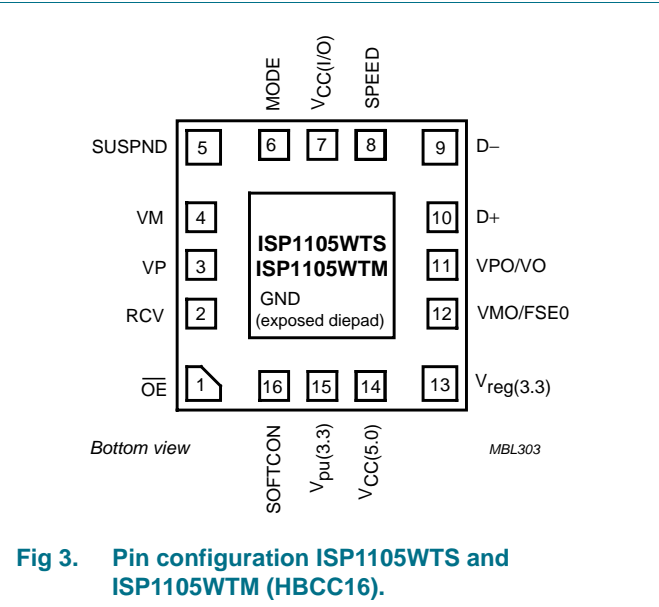


Fig 3. Pin configuration ISP1105WTS and ISP1105WTM (HBCC16).

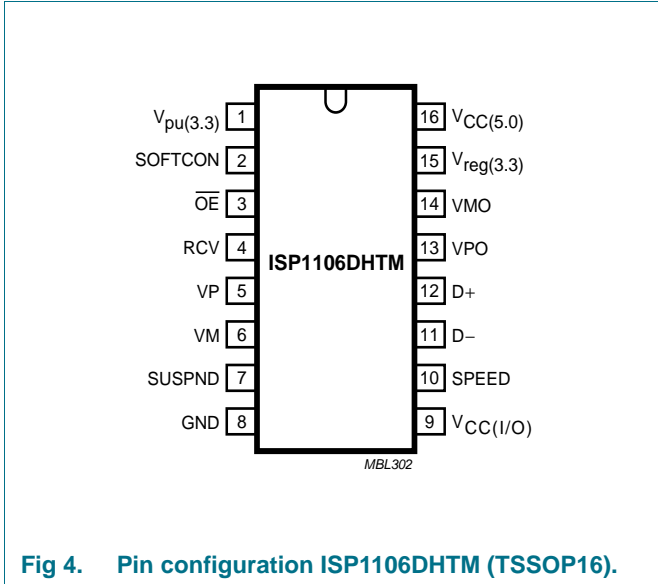


Fig 4. Pin configuration ISP1106DHTM (TSSOP16).

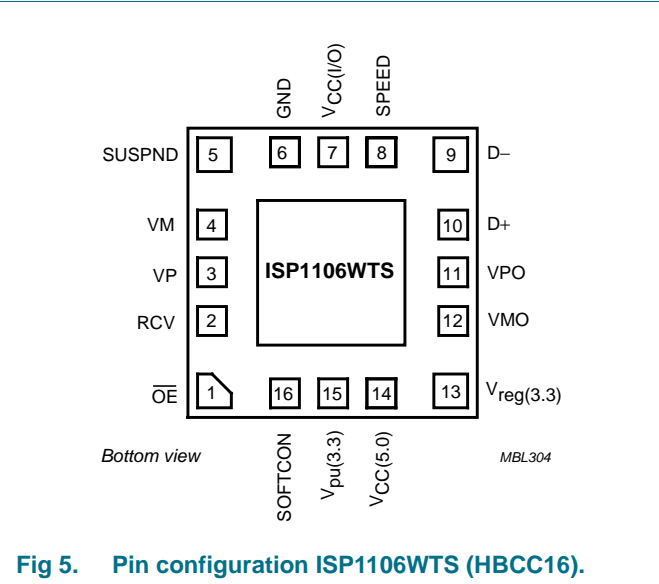


Fig 5. Pin configuration ISP1106WTS (HBCC16).

6.2 Pin description

Table 3. Pin description

Symbol ^[1]	Pin				Type	Description
	ISP1105		ISP1106			
	BSTM	WTS, WTM	DHTM	WTS		
\overline{OE}	1	1	3	1	I	output enable input (CMOS level with respect to $V_{CC(I/O)}$, active LOW); enables the transceiver to transmit data on the USB bus input pad; push pull; CMOS
RCV	2	2	4	2	O	differential data receiver output (CMOS level with respect to $V_{CC(I/O)}$); driven LOW when input SUSPND is HIGH; the output state of RCV is preserved and stable during an SE0 condition output pad; push pull; 4 mA output drive; CMOS
VP	3	3	5	3	O	single-ended D+ receiver output (CMOS level with respect to $V_{CC(I/O)}$); for external detection of single-ended zero (SE0), error conditions, speed of connected device; driven HIGH when no supply voltage is connected to $V_{CC(5.0)}$ and $V_{reg(3.3)}$ output pad; push pull; 4 mA output drive; CMOS
VM	4	4	6	4	O	single-ended D- receiver output (CMOS level with respect to $V_{CC(I/O)}$); for external detection of single-ended zero (SE0), error conditions, speed of connected device; driven HIGH when no supply voltage is connected to $V_{CC(5.0)}$ and $V_{reg(3.3)}$ output pad; push pull; 4 mA output drive; CMOS
SUSPND	5	5	7	5	I	suspend input (CMOS level with respect to $V_{CC(I/O)}$); a HIGH level enables low-power state while the USB bus is inactive and drives output RCV to a LOW level input pad; push pull; CMOS
MODE	6	6	-	-	I	mode input (CMOS level with respect to $V_{CC(I/O)}$); a HIGH level enables the differential input mode (VPO, VMO) whereas a LOW level enables a single-ended input mode (VO, FSE0); see Table 5 and Table 6 input pad; push pull; CMOS
GND	die pad	die pad	8	6	-	ground supply ^[2]
$V_{CC(I/O)}$	7	7	9	7	-	supply voltage for digital I/O pins (1.65 V to 3.6 V). When $V_{CC(I/O)}$ is not connected, the (D+, D-) pins are in three-state; this supply pin is totally independent of $V_{CC(5.0)}$ and $V_{reg(3.3)}$ and must never exceed the $V_{reg(3.3)}$ voltage
SPEED	8	8	10	8	I	speed selection input (CMOS level with respect to $V_{CC(I/O)}$); adjusts the slew rate of differential data outputs D+ and D- according to the transmission speed LOW — low-speed (1.5 Mbit/s) HIGH — full-speed (12 Mbit/s) input pad; push pull; CMOS
D-	9	9	11	9	A/I/O	negative USB data bus connection (analog, differential); for low-speed mode connect to pin $V_{pu(3.3)}$ via a 1.5 k Ω resistor
D+	10	10	12	10	A/I/O	positive USB data bus connection (analog, differential); for full-speed mode connect to pin $V_{pu(3.3)}$ via a 1.5 k Ω resistor

Table 3. Pin description ...continued

Symbol ^[1]	Pin				Type	Description
	ISP1105		ISP1106			
	BSTM	WTS, WTM	DHTM	WTS		
VPO/VO	11	11	-	-	I	driver data input (CMOS level with respect to $V_{CC(I/O)}$, Schmitt trigger); see Table 5 and Table 6
VPO	-	-	13	11		input pad; push pull; CMOS
VO	-	-	-	-		
VMO/FSE0	12	12	-	-	I	driver data input (CMOS level with respect to $V_{CC(I/O)}$, Schmitt trigger); see Table 5 and Table 6
VMO	-	-	14	12		input pad; push pull; CMOS
FSE0	-	-	-	-		
$V_{reg(3.3)}$	13	13	15	13	-	<p>internal regulator option: regulated supply voltage output (3.0 V to 3.6 V) during 5 V operation; a decoupling capacitor of at least 0.1 μF is required</p> <p>regulator bypass option: used as a supply voltage input for 3.3 V \pm 10 % operation</p>
$V_{CC(5.0)}$	14	14	16	14	-	<p>internal regulator option: supply voltage input (4.0 V to 5.5 V); can be connected directly to USB supply V_{BUS}</p> <p>regulator bypass option: connect to $V_{reg(3.3)}$</p>
$V_{pu(3.3)}$	15	15	1	15	-	<p>pull-up supply voltage (3.3 V \pm 10 %); connect an external 1.5 kΩ resistor on D+ (full-speed) or D- (low-speed); pin function is controlled by input SOFTCON</p> <p>SOFTCON = LOW — $V_{pu(3.3)}$ floating (high impedance); ensures zero pull-up current</p> <p>SOFTCON = HIGH — $V_{pu(3.3)} = 3.3$ V; internally connected to $V_{reg(3.3)}$</p>
SOFTCON	16	16	2	16	I	<p>software controlled USB connection input; a HIGH level applies 3.3 V to pin $V_{pu(3.3)}$, which is connected to an external 1.5 kΩ pull-up resistor; this allows USB connect/disconnect signalling to be controlled by software</p> <p>input pad; push pull; CMOS</p>

[1] Symbol names with an overscore (e.g. \overline{NAME}) indicate active LOW signals.

[2] ISP1105: ground terminal is connected to the exposed die pad (heat sink).

7. Functional description

7.1 Function selection

Table 4. Function table

SUSPND	\overline{OE}	(D+, D-)	RCV	VP/VM	Function
L	L	driving and receiving	active	active	normal driving (differential receiver active)
L	H	receiving ^[1]	active	active	receiving
H	L	driving	inactive ^[2]	active	driving during 'suspend' ^[3] (differential receiver inactive)
H	H	high-Z ^[1]	inactive ^[2]	active	low-power state

[1] Signal levels on (D+, D-) are determined by other USB devices and external pull-up/down resistors.

[2] In 'suspend' mode (SUSPND = HIGH) the differential receiver is inactive and output RCV is always LOW. Out-of-suspend ('K') signalling is detected via the single-ended receivers VP and VM.

[3] During suspend, the slew-rate control circuit of low-speed operation is disabled. The (D+, D-) lines are still driven to their intended states, without slew-rate control. This is permitted because driving during suspend is used to signal remote wake-up by driving a 'K' signal (one transition from idle to 'K' state) for a period of 1 to 15 ms.

7.2 Operating functions

Table 5. Driving function (pin \overline{OE} = L) using single-ended input data interface for ISP1105 (pin MODE = L)

FSE0	VO	Data
L	L	differential logic 0
L	H	differential logic 1
H	L	SE0
H	H	SE0

Table 6. Driving function (pin \overline{OE} = L) using differential input data interface for ISP1105 (pin MODE = H) and ISP1106

VMO	VPO	Data
L	L	SE0
L	H	differential logic 1
H	L	differential logic 0
H	H	illegal state

Table 7. Receiving function (pin \overline{OE} = H)

(D+, D-)	RCV	VP ^[1]	VM ^[1]
Differential logic 0	L	L	H
Differential logic 1	H	H	L
SE0	RCV* ^[2]	L	L

[1] VP = VM = H indicates the sharing mode ($V_{CC(5.0)}$ and $V_{reg(3.3)}$ are disconnected).

[2] RCV* denotes the signal level on output RCV just before SE0 state occurs. This level is stable during the SE0 period.

7.3 Power supply configurations

The ISP1105/1106 can be used with different power supply configurations, which can be changed dynamically. An overview is given in [Table 9](#).

Normal mode — Both $V_{CC(I/O)}$ and $V_{CC(5.0)}$ or ($V_{CC(5.0)}$ and $V_{reg(3.3)}$) are connected. For 5 V operation, $V_{CC(5.0)}$ is connected to a 5 V source (4.0 V to 5.5 V). The internal voltage regulator then produces 3.3 V for the USB connections. For 3.3 V operation, both $V_{CC(5.0)}$ and $V_{reg(3.3)}$ are connected to a 3.3 V source (3.0 V to 3.6 V). $V_{CC(I/O)}$ is independently connected to a voltage source (1.65 V to 3.6 V), depending on the supply voltage of the external circuit.

Disable mode — $V_{CC(I/O)}$ is not connected, $V_{CC(5.0)}$ or ($V_{CC(5.0)}$ and $V_{reg(3.3)}$) are connected. In this mode, the internal circuits of the ISP1105/1106 ensure that the (D+, D-) pins are in three-state and the power consumption drops to the low-power (suspended) state level. Some hysteresis is built into the detection of $V_{CC(I/O)}$ lost.

Sharing mode — $V_{CC(I/O)}$ is connected, ($V_{CC(5.0)}$ and $V_{reg(3.3)}$) are not connected. In this mode, the (D+, D-) pins are made three-state and the ISP1105/1106 allows external signals of up to 3.6 V to share the (D+, D-) lines. The internal circuits of the ISP1105/1106 ensure that virtually no current (maximum 10 μ A) is drawn via the (D+, D-) lines. The power consumption through pin $V_{CC(I/O)}$ drops to the low-power (suspended) state level. Both the VP and VM pins are driven HIGH to indicate this mode. Pin RCV is made LOW. Some hysteresis is built into the detection of $V_{reg(3.3)}$ lost.

Table 8. Pin states in disable or sharing mode

Pins	Disable mode state	Sharing mode state
$V_{CC(5.0)}$ / $V_{reg(3.3)}$	5 V input / 3.3 V output; 3.3 V input / 3.3 V input	not present
$V_{CC(I/O)}$	not present	1.65 V to 3.6 V input
$V_{pu(3.3)}$	high impedance (off)	high impedance (off)
(D+, D-)	high impedance	high impedance
(VP, VM)	invalid ^[1]	H
RCV	invalid ^[1]	L
Inputs (VO/VPO, FSE0/VMO, SPEED, MODE ^[2] , SUSPND, OE, SOFTCON)	high impedance	high impedance

[1] High impedance or driven LOW.

[2] ISP1105 only.

Table 9. Power supply configuration overview

$V_{CC(5.0)}$ or $V_{reg(3.3)}$	$V_{CC(I/O)}$	Configuration	Special characteristics
Connected	connected	normal mode	-
Connected	not connected	disable mode	(D+, D-) and $V_{pu(3.3)}$ high impedance; VP, VM, RCV: invalid ^[1]
Not connected	connected	sharing mode	(D+, D-) and $V_{pu(3.3)}$ high impedance; VP, VM driven HIGH; RCV driven LOW

[1] High impedance or driven LOW.

7.4 Power supply input options

The ISP1105/1106 range has two power supply input options.

Internal regulator — $V_{CC(5.0)}$ is connected to 4.0 V to 5.5 V. The internal regulator is used to supply the internal circuitry with 3.3 V (nominal). The $V_{reg(3.3)}$ pin becomes a 3.3 V output reference.

Regulator bypass — $V_{CC(5.0)}$ and $V_{reg(3.3)}$ are connected to the same supply. The internal regulator is bypassed and the internal circuitry is supplied directly from the $V_{reg(3.3)}$ power supply. The voltage range is 3.0 V to 3.6 V to comply with the USB specification.

The supply voltage range for each input option is specified in [Table 10](#).

Table 10. Power supply input options

Input option	$V_{CC(5.0)}$	$V_{reg(3.3)}$	$V_{CC(I/O)}$
Internal regulator	supply input for internal regulator (4.0 V to 5.5 V)	voltage reference output (3.3 V, 300 μ A)	supply input for digital I/O pins (1.65 V to 3.6 V)
Regulator bypass	connected to $V_{reg(3.3)}$ with maximum voltage drop of 0.3 V (2.7 V to 3.6 V)	supply input (3.0 V to 3.6 V)	supply input for digital I/O pins (1.65 V to 3.6 V)

8. Electrostatic discharge (ESD)

8.1 ESD protection

The pins that are connected to the USB connector (D+, D-, $V_{CC(5.0)}$ and GND) have a minimum of ± 12 kV ESD protection. The ± 12 kV measurement is limited by the test equipment. Capacitors of $4.7 \mu\text{F}$ connected from $V_{\text{reg}(3.3)}$ to GND and $V_{CC(5.0)}$ to GND are required to achieve this ± 12 kV ESD protection (see [Figure 6](#)).

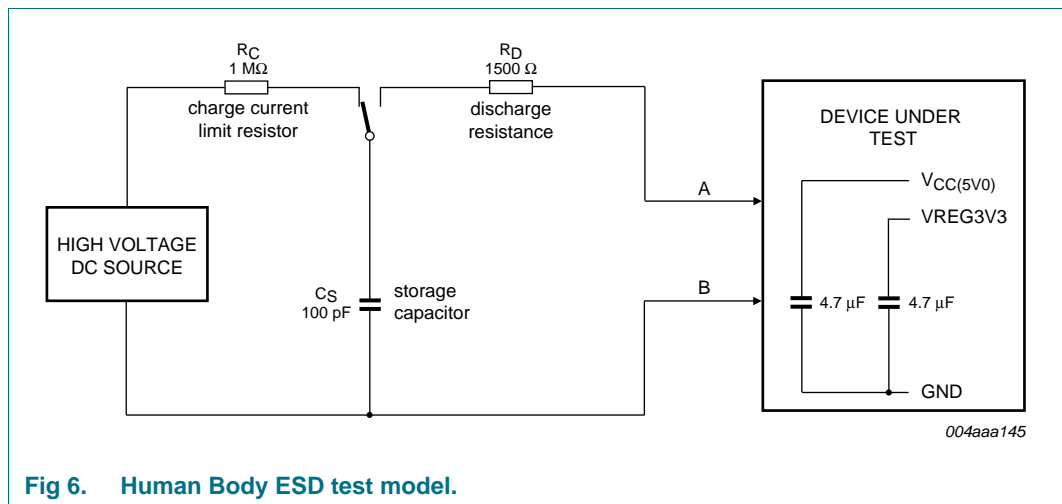


Fig 6. Human Body ESD test model.

8.2 ESD test conditions

A detailed report on test set-up and results is available on request.

9. Limiting values

Table 11. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit	
$V_{CC(5.0)}$	supply voltage		-0.5	+6.0	V	
$V_{CC(I/O)}$	I/O supply voltage		-0.5	+4.6	V	
$V_{reg(3.3)}$	regulated supply voltage		-0.5	+4.6	V	
V_I	DC input voltage		-0.5	$V_{CC(I/O)} + 0.5$	V	
I_{lu}	latch-up current	$V_I = -1.8 \text{ V to } 5.4 \text{ V}$	-	100	mA	
V_{esd}	electrostatic discharge voltage	$I_{LI} < 1 \mu\text{A}$	[1][2]			
		on pins D+, D-, $V_{CC(5.0)}$ and GND		-12000	+12000	V
		on other pins		-2000	+2000	V
T_{stg}	storage temperature		-40	+125	°C	

[1] Testing equipment limits measurement to only $\pm 12 \text{ kV}$. Capacitors needed on $V_{CC(5.0)}$ and $V_{reg(3.3)}$; see [Section 8](#).

[2] Equivalent to discharging a 100 pF capacitor via a 1.5 k Ω resistor (Human Body Model).

10. Recommended operating conditions

Table 12. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC(5.0)}$	supply voltage (internal regulator option)	5 V operation	4.0	5.0	5.5	V
$V_{reg(3.3)}$	supply voltage (regulator bypass option)	3.3 V operation	3.0	3.3	3.6	V
$V_{CC(I/O)}$	I/O supply voltage		1.65	-	3.6	V
V_I	input voltage		0	-	$V_{CC(I/O)}$	V
$V_{I(AI/O)}$	input voltage on analog I/O pins (D+/D-)		0	-	3.6	V
T_{amb}	operating ambient temperature		-40	-	+85	°C

11. Static characteristics

Table 13. Static characteristics: supply pins

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$ or $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$; $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$; $V_{GND} = 0\text{ V}$; see [Table 10](#) for valid voltage level combinations; $T_{amb} = -40\text{ °C to }+85\text{ °C}$; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{reg(3.3)}$	regulated supply voltage output	internal regulator option; $I_{load} \leq 300\text{ }\mu\text{A}$	[1][2] 3.0	3.3	3.6	V
I_{CC}	operating supply current	full-speed transmitting and receiving at 12 Mbit/s; $C_L = 50\text{ pF}$ on D+/D-	[3] -	4	8	mA
$I_{CC(I/O)}$	operating I/O supply current	full-speed transmitting and receiving at 12 Mbit/s	[3] -	1	2	mA
$I_{CC(idle)}$	supply current during full-speed idle and SE0	full-speed idle: $V_{D+} > 2.7\text{ V}$, $V_{D-} < 0.3\text{ V}$; SE0: $V_{D+} < 0.3\text{ V}$, $V_{D-} < 0.3\text{ V}$	[4] -	-	500	μA
$I_{CC(I/O)(static)}$	static I/O supply current	full-speed idle, SE0 or suspend	-	-	20	μA
$I_{CC(susp)}$	suspend supply current	SUSPND = HIGH	[4] -	-	20	μA
$I_{CC(dis)}$	disable mode supply current	$V_{CC(I/O)}$ not connected	[4] -	-	20	μA
$I_{CC(I/O)(sharing)}$	sharing mode I/O supply current	$V_{CC(5.0)}$ or $V_{reg(3.3)}$ not connected	-	-	20	μA
$I_{Dx(sharing)}$	sharing mode load current on pins D+ and D-	$V_{CC(5.0)}$ or $V_{reg(3.3)}$ not connected; SOFTCON = LOW; $V_{Dx} = 3.6\text{ V}$	-	-	10	μA
$V_{reg(3.3)th}$	regulated supply voltage detection threshold	$1.65\text{ V} \leq V_{CC(I/O)} \leq V_{reg(3.3)}$; $2.7\text{ V} \leq V_{reg(3.3)} \leq 3.6\text{ V}$				
		supply lost	-	-	0.8	V
		supply present	[5] 2.4	-	-	V
$V_{reg(3.3)hys}$	regulated supply voltage detection hysteresis	$V_{CC(I/O)} = 1.8\text{ V}$	-	0.45	-	V
$V_{CC(I/O)th}$	I/O supply voltage detection threshold	$V_{reg(3.3)} = 2.7\text{ V to }3.6\text{ V}$				
		supply lost	-	-	0.5	V
		supply present	1.4	-	-	V
$V_{CC(I/O)hys}$	I/O supply voltage detection hysteresis	$V_{reg(3.3)} = 3.3\text{ V}$	-	0.45	-	V

[1] I_{load} includes the pull-up resistor current via pin $V_{pu(3.3)}$.

[2] In 'suspend' mode, the minimum voltage is 2.7 V.

[3] Maximum value is characterized only, not tested in production.

[4] Excluding any load current and $V_{pu(3.3)}/V_{sw}$ source current to the 1.5 k Ω and 15 k Ω pull-up and pull-down resistors (200 μA typ.).

[5] When $V_{CC(I/O)} < 2.7\text{ V}$, the minimum value for $V_{th(reg3.3)(present)}$ is 2.0 V.

Table 14. Static characteristics: digital pins

$V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$; $V_{GND} = 0\text{ V}$; $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC(I/O)} = 1.65\text{ to }3.6\text{ V}$						
Input levels						
V_{IL}	LOW-level input voltage		-	-	$0.3V_{CC(I/O)}$	V
V_{IH}	HIGH-level input voltage		$0.6V_{CC(I/O)}$	-	-	V
Output levels						
V_{OL}	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
V_{OH}	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	$V_{CC(I/O)} - 0.15$	-	-	V
		$I_{OH} = 2\text{ mA}$	$V_{CC(I/O)} - 0.4$	-	-	V
Leakage current						
I_{LI}	input leakage current		-1	-	+1	μA
Example 1: $V_{CC(I/O)} = 1.8\text{ V} \pm 0.15\text{ V}$						
Input levels						
V_{IL}	LOW-level input voltage		-	-	0.5	V
V_{IH}	HIGH-level input voltage		1.2	-	-	V
Output levels						
V_{OL}	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
V_{OH}	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	1.5	-	-	V
		$I_{OH} = 2\text{ mA}$	1.25	-	-	V
Example 2: $V_{CC(I/O)} = 2.5\text{ V} \pm 0.2\text{ V}$						
Input levels						
V_{IL}	LOW-level input voltage		-	-	0.7	V
V_{IH}	HIGH-level input voltage		1.7	-	-	V
Output levels						
V_{OL}	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
V_{OH}	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	2.15	-	-	V
		$I_{OH} = 2\text{ mA}$	1.9	-	-	V
Example 3: $V_{CC(I/O)} = 3.3\text{ V} \pm 0.3\text{ V}$						
Input levels						
V_{IL}	LOW-level input voltage		-	-	0.9	V
V_{IH}	HIGH-level input voltage		2.15	-	-	V
Output levels						
V_{OL}	LOW-level output voltage	$I_{OL} = 100\text{ }\mu\text{A}$	-	-	0.15	V
		$I_{OL} = 2\text{ mA}$	-	-	0.4	V
V_{OH}	HIGH-level output voltage	$I_{OH} = 100\text{ }\mu\text{A}$	2.85	-	-	V
		$I_{OH} = 2\text{ mA}$	2.6	-	-	V
Capacitance						
C_{IN}	input capacitance	pin to GND	-	-	10	pF

Table 15. Static characteristics: analog I/O pins (D+, D-)

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$ or $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$; $V_{GND} = 0\text{ V}$; $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Input levels						
Differential receiver						
V_{DI}	differential input sensitivity	$ V_{I(D+)} - V_{I(D-)} $	0.2	-	-	V
V_{CM}	differential common mode voltage	includes V_{DI} range	0.8	-	2.5	V
Single-ended receiver						
V_{IL}	LOW-level input voltage		-	-	0.8	V
V_{IH}	HIGH-level input voltage		2.0	-	-	V
V_{hys}	hysteresis voltage		0.4	-	0.7	V
Output levels						
V_{OL}	LOW-level output voltage	$R_L = 1.5\text{ k}\Omega$ to +3.6 V	-	-	0.3	V
V_{OH}	HIGH-level output voltage	$R_L = 15\text{ k}\Omega$ to GND	[1] 2.8	-	3.6	V
Leakage current						
I_{LZ}	OFF-state leakage current		-1	-	+1	μA
Capacitance						
C_{IN}	transceiver capacitance	pin to GND	-	-	20	pF
Resistance						
Z_{DRV}	driver output impedance	steady-state drive	[2] 34	39	44	Ω
Z_{INP}	input impedance		10	-	-	$\text{M}\Omega$
R_{SW}	internal switch resistance at pin $V_{pu(3.3)}$		-	-	10	Ω
Termination						
V_{TERM}	termination voltage for upstream port pull-up (R_{PU})		[3][4] 3.0	-	3.6	V

[1] $V_{OH(min)} = V_{reg(3.3)} - 0.2\text{ V}$.

[2] Includes external resistors of $33\ \Omega \pm 1\%$ on both D+ and D-.

[3] This voltage is available at pins $V_{reg(3.3)}$ and $V_{pu(3.3)}$.

[4] In 'suspend' mode the minimum voltage is 2.7 V.

12. Dynamic characteristics

Table 16. Dynamic characteristics: analog I/O pins (D+, D-)

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$ or $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$; $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$; $V_{GND} = 0\text{ V}$; see [Table 10](#) for valid voltage level combinations; $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$; unless otherwise specified.^[1]

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Driver characteristics						
Full-speed mode						
t_{FR}	rise time	$C_L = 50\text{ pF to }125\text{ pF}$; 10 % to 90 % of $ V_{OH} - V_{OL} $; see Figure 7	4	-	20	ns
t_{FF}	fall time	$C_L = 50\text{ pF to }125\text{ pF}$; 90 % to 10 % of $ V_{OH} - V_{OL} $; see Figure 7	4	-	20	ns
FRFM	differential rise/fall time matching (t_{FR}/t_{FF})	excluding the first transition from idle state	90	-	111.1	%
V_{CRS}	output signal crossover voltage	excluding the first transition from idle state; see Figure 10	[2] 1.3	-	2.0	V
Low-speed mode						
t_{LR}	rise time	$C_L = 50\text{ pF to }600\text{ pF}$; 10 % to 90 % of $ V_{OH} - V_{OL} $; see Figure 7	75	-	300	ns
t_{LF}	fall time	$C_L = 50\text{ pF to }600\text{ pF}$; 90 % to 10 % of $ V_{OH} - V_{OL} $; see Figure 7	75	-	300	ns
LRFM	differential rise/fall time matching (t_{LR}/t_{LF})	excluding the first transition from idle state	80	-	125	%
V_{CRS}	output signal crossover voltage	excluding the first transition from idle state; see Figure 10	[2] 1.3	-	2.0	V
Driver timing						
Full-speed mode						
$t_{PLH(drv)}$	driver propagation delay (VO/VPO, FSE0/VMO to D+,D-)	LOW-to-HIGH; see Figure 10	-	-	18	ns
$t_{PHL(drv)}$	driver propagation delay (VO/VPO, FSE0/VMO to D+,D-)	HIGH-to-LOW; see Figure 10	-	-	18	ns
t_{PHZ}	driver disable delay (\overline{OE} to D+,D-)	HIGH-to-OFF; see Figure 8	-	-	15	ns
t_{PLZ}	driver disable delay (\overline{OE} to D+,D-)	LOW-to-OFF; see Figure 8	-	-	15	ns
t_{PZH}	driver enable delay (\overline{OE} to D+,D-)	OFF-to-HIGH; see Figure 8	-	-	15	ns
t_{PZL}	driver enable delay (\overline{OE} to D+,D-)	OFF-to-LOW; see Figure 8	-	-	15	ns
Low-speed mode						

Not specified: low-speed delay timings are dominated by the slow rise/fall times t_{LR} and t_{LF} .

Table 16. Dynamic characteristics: analog I/O pins (D+, D-) ...continued

$V_{CC} = 4.0\text{ V to }5.5\text{ V}$ or $V_{reg(3.3)} = 3.0\text{ V to }3.6\text{ V}$; $V_{CC(I/O)} = 1.65\text{ V to }3.6\text{ V}$; $V_{GND} = 0\text{ V}$; see [Table 10](#) for valid voltage level combinations; $T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}$; unless otherwise specified.[1]

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Receiver timings (full-speed and low-speed mode)						
Differential receiver						
$t_{PLH(rcv)}$	propagation delay (D+,D- to RCV)	LOW-to-HIGH; see Figure 9	-	-	15	ns
$t_{PHL(rcv)}$	propagation delay (D+,D- to RCV)	HIGH-to-LOW; see Figure 9	-	-	15	ns
Single-ended receiver						
$t_{PLH(se)}$	propagation delay (D+,D- to VP, VM)	LOW-to-HIGH; see Figure 9	-	-	18	ns
$t_{PHL(se)}$	propagation delay (D+,D- to VP, VM)	HIGH-to-LOW; see Figure 9	-	-	18	ns

[1] Test circuit: see [Figure 13](#).

[2] Characterized only, not tested. Limits guaranteed by design.

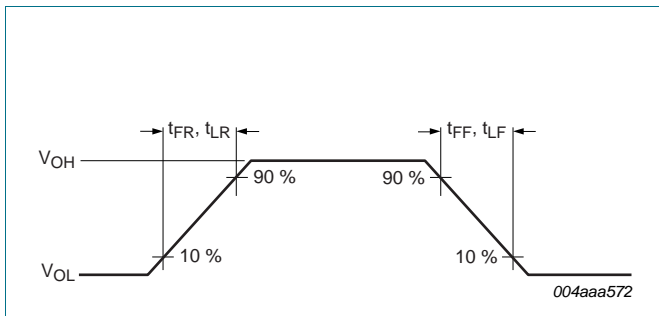


Fig 7. Rise and fall times.

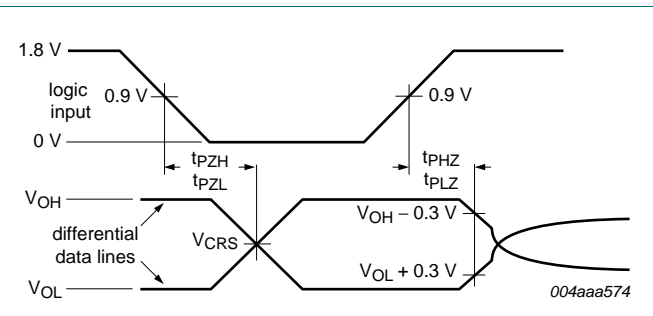


Fig 8. Timing of \overline{OE} to D+, D-.

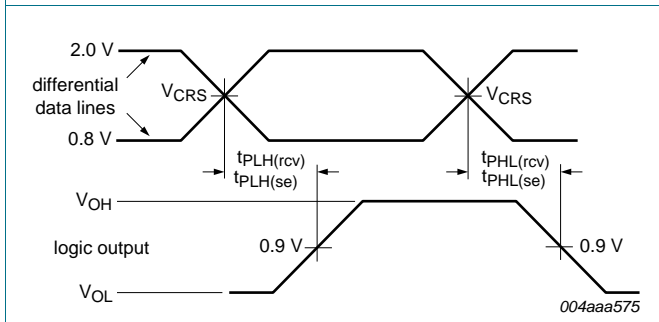


Fig 9. Timing of D+, D- to RCV, VP, VM.

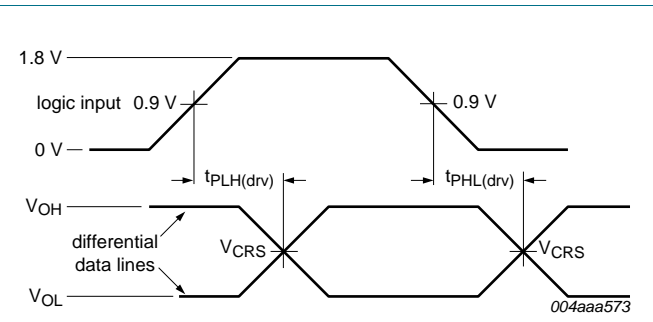
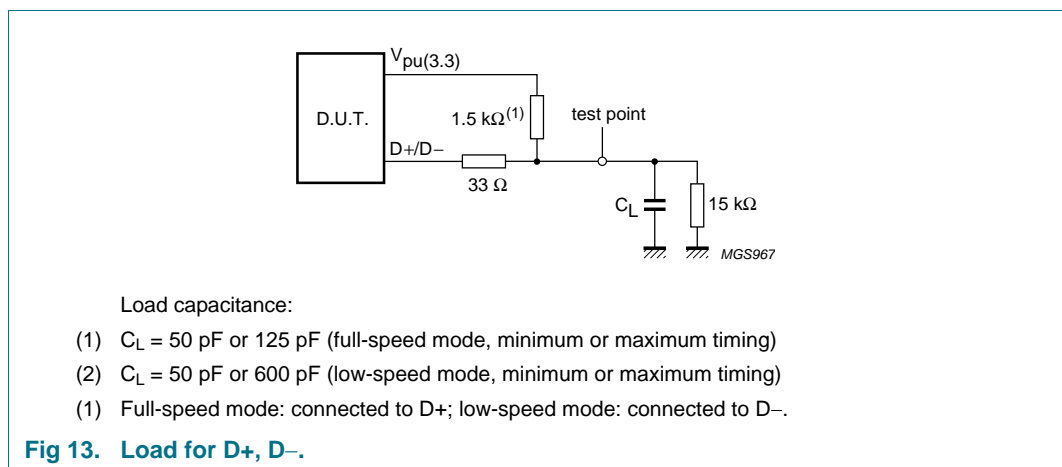
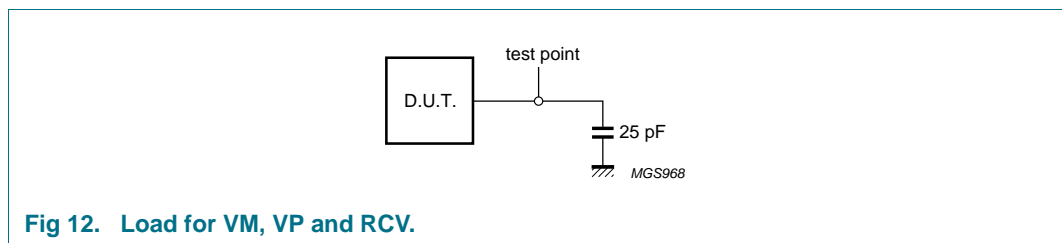
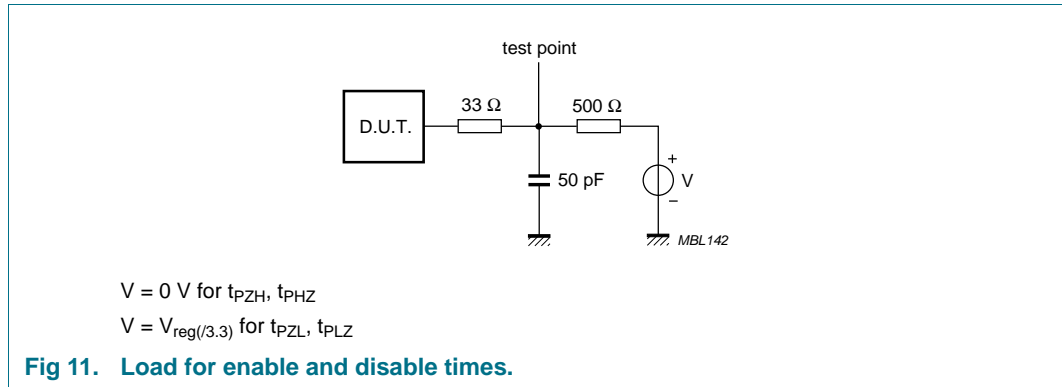


Fig 10. Timing of VO/VPO, FSE0/VMO to D+, D-.

13. Test information



14. Package outline

HBCC16: plastic thermal enhanced bottom chip carrier; 16 terminals; body 3 x 3 x 0.65 mm

SOT639-2

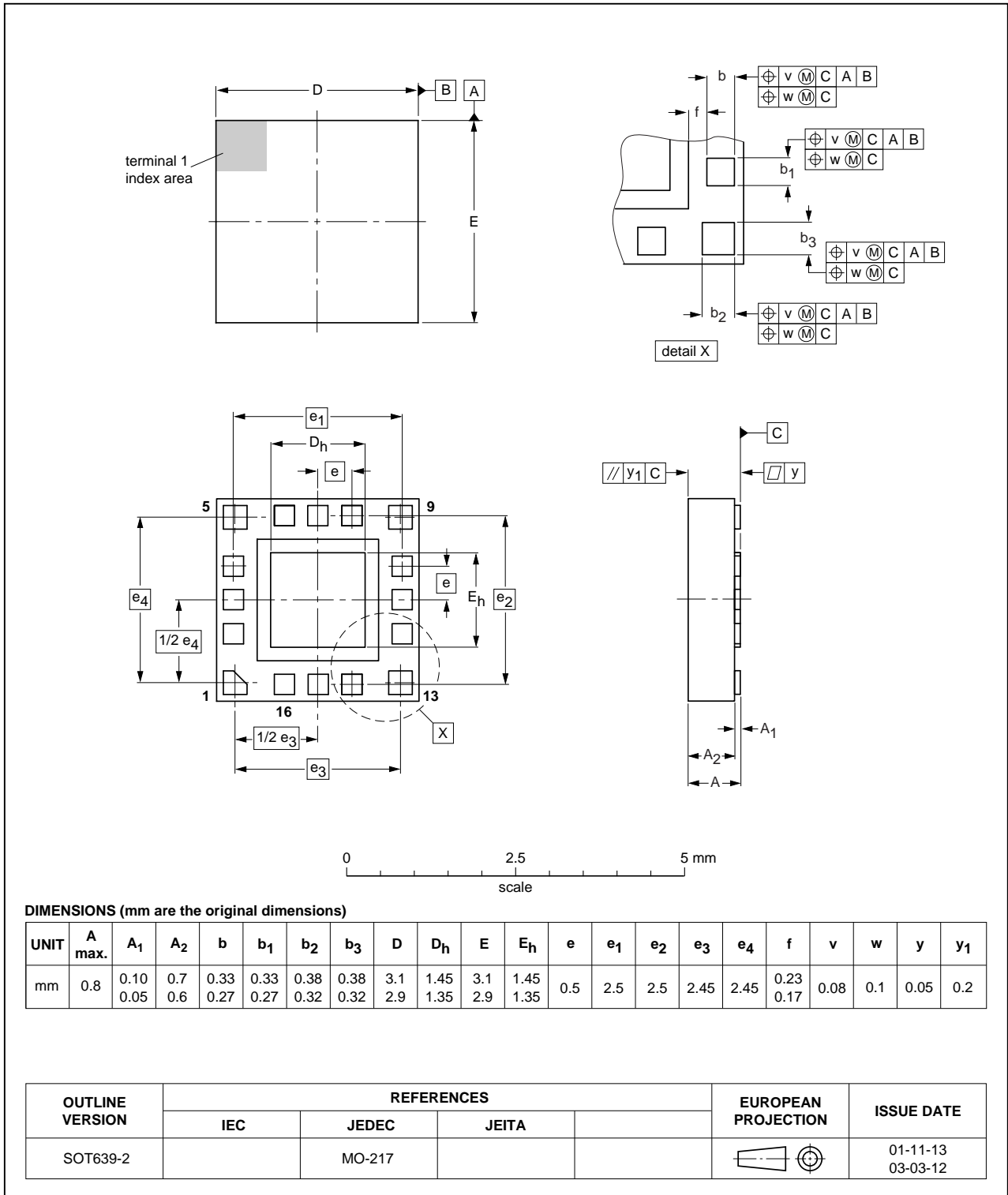


Fig 14. HBCC16 package outline.

HVQFN16: plastic thermal enhanced very thin quad flat package; no leads; 16 terminals; body 3 x 3 x 0.85 mm

SOT758-1

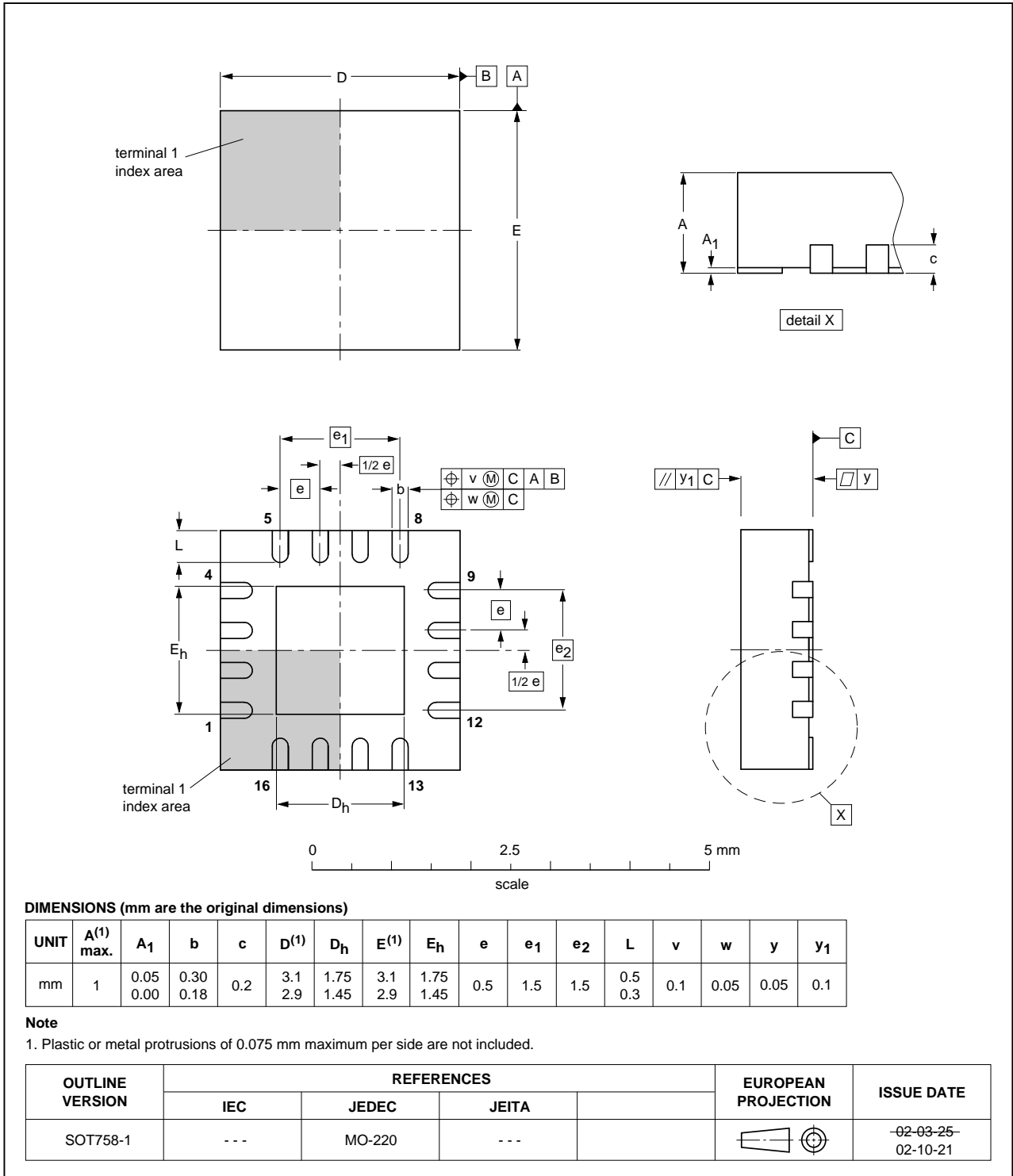


Fig 15. HVQFN16 package outline.

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

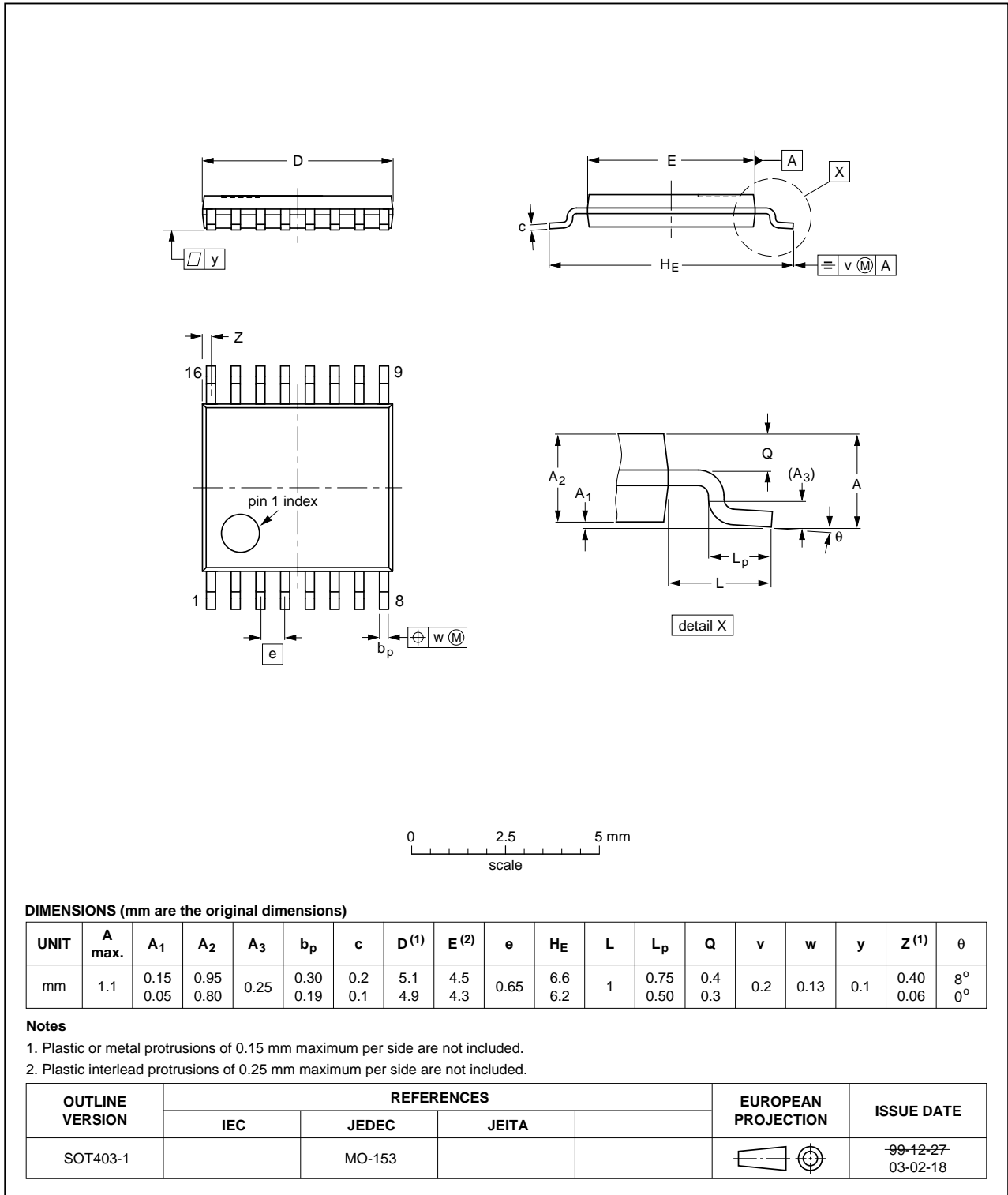


Fig 16. TSSOP16 package outline.

15. Revision history

Table 17. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
ISP1105_1106_10	20090928	Product data sheet	-	ISP1105_1106_9
Modifications:	<ul style="list-style-type: none"> • Rebranded to the ST-Ericsson template. • Section 2 "Features": updated. • Section 4 "Ordering information": updated. • Removed packing information. • Removed soldering information. 			
ISP1105_1106_9	20090119	Product data sheet	-	ISP1105_1106-08
ISP1105_1106-08 (9397 750 09529)	20040219	Product data	-	ISP1105_1106_1107-07
ISP1105_1106_1107-07 (9397 750 08872)	20020329	Product data	-	ISP1105_1106_1107-06
ISP1105_1106_1107-06 (9397 750 08681)	20011130	Product data	-	ISP1105_1106_1107-05
ISP1105_1106_1107-05 (9397 750 08643)	20010903	Product data	-	ISP1105_1106_1107-04
ISP1105_1106_1107-04 (9397 750 08515)	20010802	Preliminary data	-	ISP1105_1106_1107-03
ISP1105_1106_1107-03 (9397 750 07879)	20010704	Preliminary data	-	ISP1107-02
ISP1107-02 (9397 750 06899)	20010205	Objective specification; ISP1107 stand-alone data sheet only	-	ISP1107-01
ISP1107-01 (9397 750 08643)	20000223	Objective specification; ISP1107 stand-alone data sheet only	--	-

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